# On-Die Decoupling Model Improvements for IBIS Power Aware Models

Randy Wolff and Aniello Viscardi
Micron Technology
Asian IBIS Summit
November 11, 2016, Shanghai, China
(Previously given at the European IBIS Summit
May 11, 2016 Turin, Italy)

©2016 Micron Technology, Inc. All rights reserved. Information, products, and/or specifications are subject to change without notice. All information is provided on an "AS IS" basis without warranties of any kind. Statements regarding products, including regarding their features, availability, functionality, or compatibility, are provided for informational purposes only and do not modify the warranty, if any, applicable to any product. Drawings may not be to scale. Micron, the Micron logo, and all other Micron trademarks are the property of Micron Technology, Inc. All other trademarks are the property of their respective owners.



### **Outline**

- IBIS Power-aware modeling overview
- On-die Decoupling models
- Multi-port Decoupling models
- Example Simulations
- Conclusions

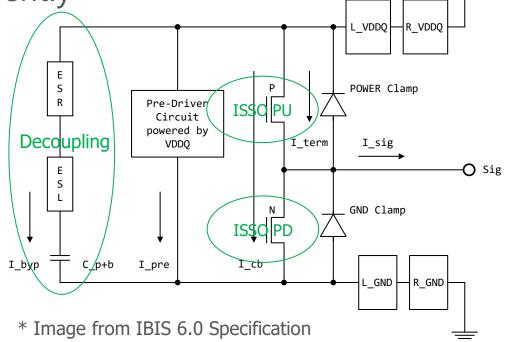


### **IBIS Power-aware Modeling Overview**

Power Integrity modeling uses [Composite Current], [ISSO PU], [ISSO PD] and an IBIS-ISS on-die decoupling circuit model

Decoupling model external to IBIS currently

```
I byp
         - Bypass current
I pre
         - Pre-Driver current
I cb
         - Crow-bar current
I term
         - Termination current (optional)
L VDDQ
         - On-die inductance of I/O Power
R VDDQ
         - On-die resistance of I/O Power
L GND
         - On-die inductance of Ground
R GND
         - On-die resistance of Ground
C p+b
         - Bypass + Parasitic Capacitance
ESR
         - Equivalent Series Resistance for on-die Decap
         - Equivalent Series Inductance for on-die Decap
ESL
```

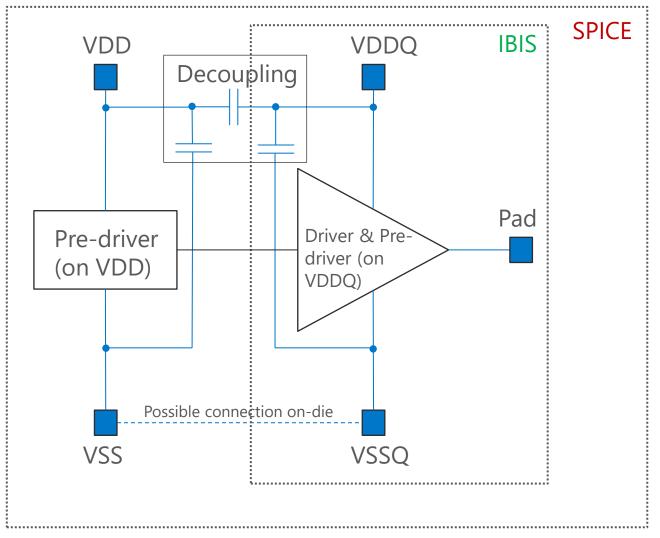


[Composite Current]



### **On-die Decoupling Models**

- SPICE model may have pre-driver circuits on separate power supplies
- May be one common ground ondie
- Decoupling model could include VDDQ, VSSQ, VDD, VSS
- What is needed for IBIS to correlate with SPICE?





### Multi-port Decoupling Models

- Decoupling circuits may contain proprietary modeling equations or process data
- A non-proprietary model can be an S-parameter or a broadband SPICE macromodel (of the S-parameter characterization)
- S-parameter port options
  - 1-port: VDDQ with VSSQ reference
  - 2-port: VDDQ, VSSQ, with 0 reference
  - 3 or [4] port: VDDQ, VSSQ, VDD, [VSS], with 0 reference



## SPICE Setup Examples for Decoupling Model Creation

- Buffer Instance in Hi-Z state:
  - Xbuff ... VDDQ\_die VSSQ\_die ... Buffer\_name

#### Port Definition:

- Single Port
  - P1 VDDQ\_die VSSQ\_die port=1 Z0=50 DC VDDQ
- Multi Port
  - P1 VDDQ\_die 0 port=1 Z0=50 DC VDDQ
  - P2 VSSQ\_die 0 port=2 Z0=50 DC 0

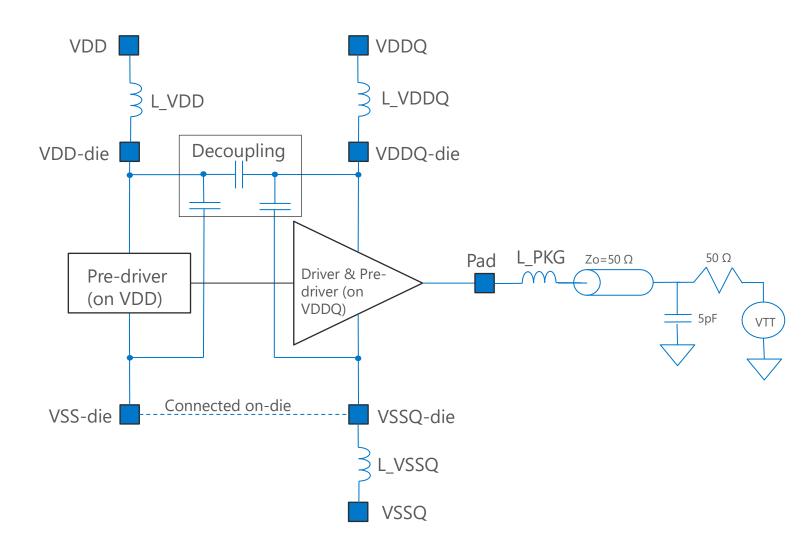
### AC Analysis

- .lin sparcalc=1 filename='s\_model.sNp' format=touchstone dataformat=ma freqdigit=10 spardigit=10
- .ac dec 100 1 10e12



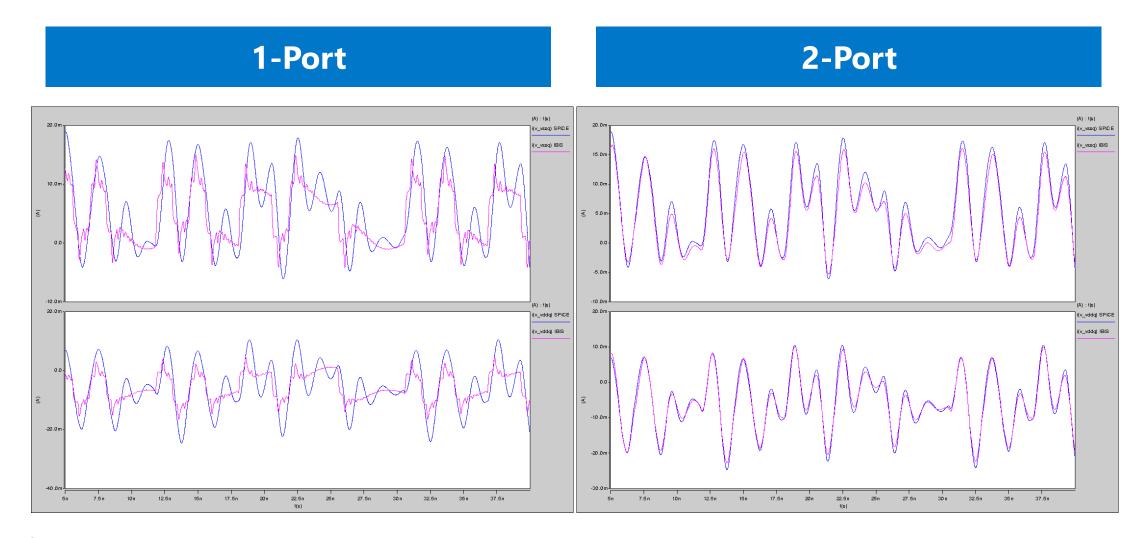
# Example Simulation 1 – Ideal VDD Comparing Transistor-level and IBIS Model in SPICE

- L\_VDD=0 (short)
- L\_VDDQ=1.25nH
- L\_VSSQ=1.25nH
- L\_PKG=1.25nH



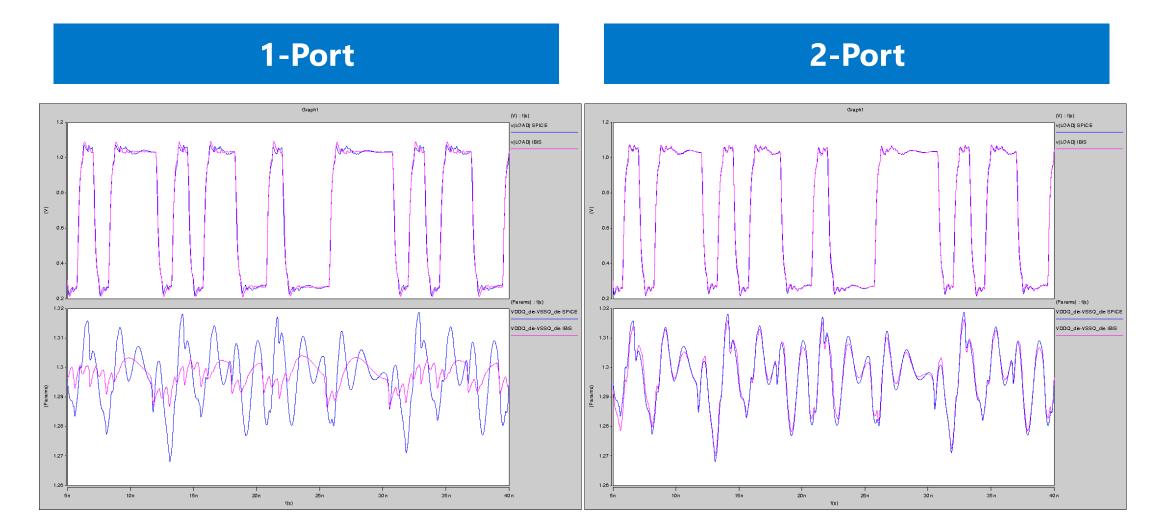


### 1-Port vs. 2-Port Models, I(VSSQ) and I(VDDQ)





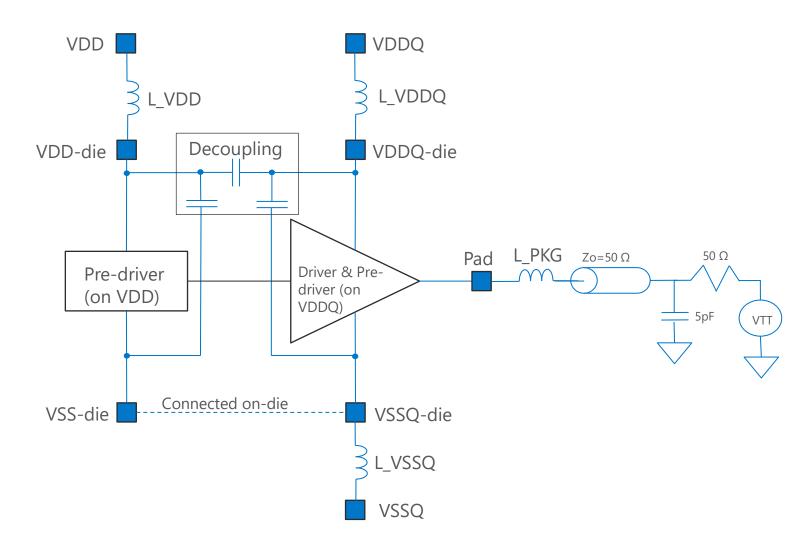
### V(LOAD) and V(VDDQ\_die)-V(VSSQ\_die)





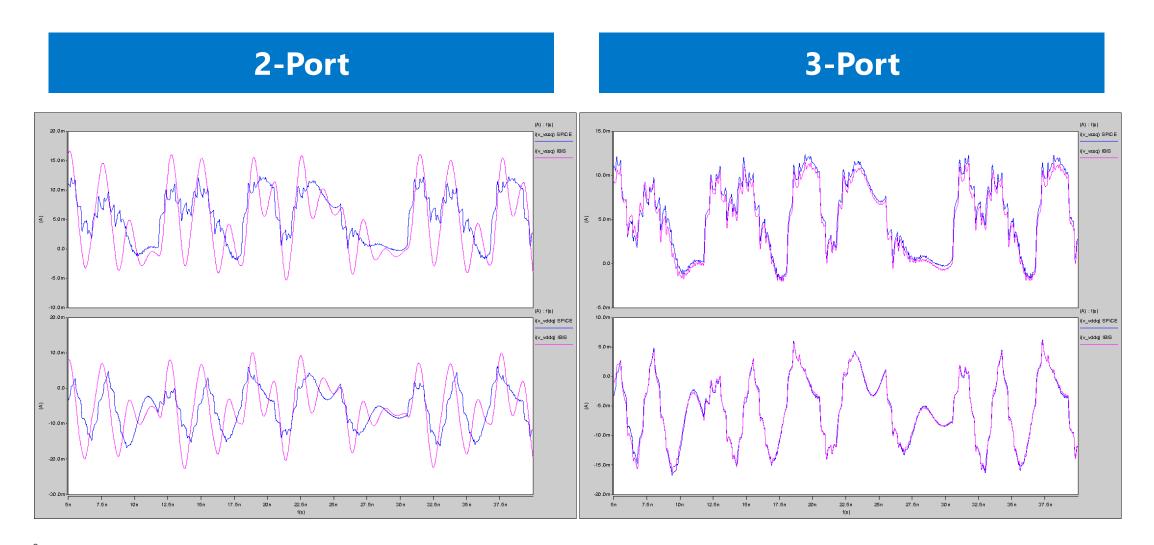
# Example Simulation 2 – Non-ideal VDD Comparing Transistor-level and IBIS Model in SPICE

- L VDD=1.25nH
- L\_VDDQ=1.25nH
- L VSSQ=1.25nH
- L PKG=1.25nH



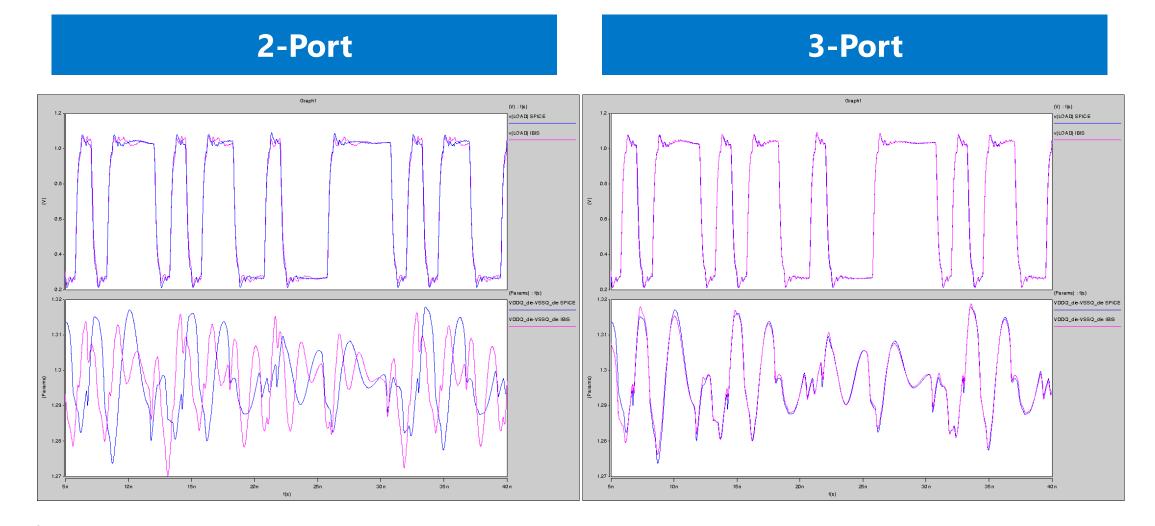


# 2-Port vs. 3-Port Models, I(VSSQ) and I(VDDQ)





### V(LOAD) and V(VDDQ\_die)-V(VSSQ\_die)





### Conclusions

- A 2-port S-parameter (3-terminal macro-model) for on-die decoupling is a better model than a 1-port model for power-aware simulations.
  - This solution requires use of node 0 in the decoupling model.
- Correlating to a SPICE simulation that includes non-ideal supply connections to pre-driver circuits requires extra ports for non-ideal supplies in the decoupling model.
- A multi-port decoupling model is most versatile. Unused ports not connected to a package model should be connected to 0.
- The new IBIS Interconnect BIRD will allow the IBIS-ISS decoupling model to be connected properly to the package model.



